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## NTE5491 thru NTE5496 Silicon Controlled Rectifier (SCR) 10 Amp

### **Description:**

The NTE5491 through NTE5496 are silicon controlled rectifiers designed primarily for half-wave AC control applications such as motor controls, heating controls, power supplies, or wherever half-wave silicon gate-controlled, solid-state devices are needed.

### **Features:**

- Glass-Passivated Junctions and Center Gate Fire for Greater Parameter Uniformity and Stability
- Blocking Voltage to 600 Volts

### **Absolute Maximum Ratings:** ( $T_J = +125^\circ\text{C}$ unless otherwise specified)

Peak Repetitive Off-State Blocking Voltage,  $V_{RRM}$ ,  $V_{DRM}$

|               |      |
|---------------|------|
| NTE5491 ..... | 100V |
| NTE5492 ..... | 200V |
| NTE5494 ..... | 400V |
| NTE5496 ..... | 600V |

Peak Non-Repetitive Reverse Voltage,  $V_{RSM}$

|               |      |
|---------------|------|
| NTE5491 ..... | 150V |
| NTE5492 ..... | 300V |
| NTE5494 ..... | 500V |
| NTE5496 ..... | 720V |

RMS On-State Current (All Conduction Angles),  $I_{T(RMS)}$  ..... 25A

Average On-State Current ( $T_C = +65^\circ\text{C}$ ),  $I_{T(AV)}$  ..... 16A

Peak Non-Repetitive Surge Current,  $I_{TSM}$   
(One cycle, 60Hz, Preceeded and followed by rated Current and Voltage) ..... 150A

Circuit Fusing Considerations ( $T_J = -40^\circ$  to  $+125^\circ\text{C}$ ,  $t = 1$  to 8.3ms),  $I^2t$  ..... 93A<sup>2</sup>s

Peak Gate Power Dissipation,  $P_{GM}$  ..... 5W

Average Gate Power Dissipation,  $P_{G(AV)}$  ..... 500mW

Peak Forward Gate Current,  $I_{GT}$   
NTE5491, NTE5492, NTE5494 ..... 2.0A  
NTE5496 ..... 1.2A

Operating Junction Temperature Range,  $T_J$  .....  $-65^\circ$  to  $+125^\circ\text{C}$

Storage Temperature Range,  $T_{stg}$  .....  $-65^\circ$  to  $+150^\circ\text{C}$

Typical Thermal Resistance, Junction-to-Case,  $R_{thJC}$  ..... 2°C/W

Stud Torque ..... 30 in.lb.

**Electrical Characteristics:** ( $T_J = +25^\circ\text{C}$  unless otherwise specified)

| Parameter                                   | Symbol      | Test Conditions   | Min  | Typ  | Max | Unit                   |
|---|-------------|---|------|------|-----|------------------------|
| Average Forward Blocking Current<br>NTE5491 | $I_{D(AV)}$ | Rated $V_{DRM}$ , Gate Open<br>$T_J = +125^\circ\text{C}$                         | —    | —    | 6.5 | mA                     |
| NTE5492                                     |             |   | —    | —    | 6.0 | mA                     |
| NTE5494                                     |             |   | —    | —    | 4.0 | mA                     |
| NTE5496                                     |             |   | —    | —    | 2.5 | mA                     |
| Average Reverse Blocking Current<br>NTE5491 | $I_{R(AV)}$ | Rated $V_{RRM}$ , Gate Open<br>$T_J = +125^\circ\text{C}$                         | —    | —    | 6.5 | mA                     |
| NTE5492                                     |             |   | —    | —    | 6.0 | mA                     |
| NTE5494                                     |             |   | —    | —    | 4.0 | mA                     |
| NTE5496                                     |             |   | —    | —    | 2.5 | mA                     |
| Peak Forward Blocking Current               | $I_{DRM}$   | Rated $V_{DRM}$ , Gate Open   | —    | —    | 10  | $\mu\text{A}$          |
| Peak Reverse Blocking Current               | $I_{RRM}$   | Rated $V_{RRM}$ , Gate Open,<br>$T_J = +125^\circ\text{C}$                        | —    | —    | 20  | mA                     |
| Peak On-State Voltage                       | $V_{TM}$    | $I_{TM} = 50.3\text{A}$ Peak, Note 1  | —    | —    | 2   | V                      |
| DC Gate-Trigger Current                     | $I_{GT}$    | $V_{AK} = 12\text{VDC}$ , $R_L = 50\Omega$  | —    | —    | 40  | mA                     |
| DC Gate-Trigger Voltage                     | $V_{GT}$    | $V_{AK} = 12\text{VDC}$ , $R_L = 50\Omega$  | —    | 0.65 | 2.0 | V                      |
| Gate Non-Trigger Voltage                    | $V_{GD}$    | Rated $V_{DRM}$ , $R_L = 50\Omega$ , $T_J = +125^\circ\text{C}$                   | 0.25 | —    | —   | V                      |
| DC Holding Current                          | $I_H$       | $V_{AK} = 12\text{V}$ , Gate Open   | —    | 7.3  | 50  | mA                     |
| Critical Rate-of-Rise of Off-State Voltage  | $dv/dt$     | Rated $V_{DRM}$ , Exponential Waveform,<br>$T_C = +125^\circ\text{C}$ , Gate Open | —    | 30   | —   | $\text{V}/\mu\text{s}$ |

Note 1. Pulse Test: Pulse Width  $\leq 1\text{ms}$ , Duty Cycle  $\leq 2\%$ .

